PCN Number: 202				031001.1 <b>PCN Date:</b>			November 01, 2022			
Title: Qualification of CF				AB and additional assembly BOM options for select LBC4 devices					elect LBC4 devices	
Customer	Contact:		PC	CN	Manager		De	Dept:		Quality Services
Proposed 1 <sup>st</sup> Ship Date:						requests ted until: Nov 30, 202		Nov 30, 2022*		
*Sample requests received after November 30, 2022 will not be supported.						orted.				
Change Type:										
Assen	nbly Site				Assembly Process			$\boxtimes$	Assembly Materials	
Design	า				Electrical Specificat	ion			Mechanical Specification	
☐ Test S	Site				Packing/Shipping/L	abeling			Test Process	
Wafer	Bump Site		☐ Wafer Bump Material					Wafer Bump Process		
	Fab Site						Wafer Fab Process			
			☐ Part number change			•				
	PCN Details									

#### **Description of Change:**

Texas Instruments is pleased to announce the qualification of a new fab site (CFAB) and assembly BOM options for selected devices as listed below in the product affected section.

	Current Fa	b Site	New Fab Site			
Fab Site	Process Wafer Diameter		Fab Site	Process	Wafer Diameter	
DL-LIN	LBC4	150 mm	CFAB	LBC4	200 mm	
DL-LIN	LBC4	200 mm	CFAB	LDC4	200 111111	

Additionally, there will be assembly BOM options introduced for these devices:

#### Group 2: (DFAB to CFAB Wafer Fab site & BOM update)

	Current	Additional
Bond wire composition, diameter	Au, 0.96 mils	Cu, 0.96 mils
Mold Compound	4211471	4205442
Mount Compound	4147858	4211470

#### **Reason for Change:**

These changes are part of our multiyear plan to transition products from our 150-milimeter factories to newer, more efficient manufacturing processes and technologies, underscoring our commitment to product longevity and supply continuity.

#### Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):

None

#### **Impact on Environmental Ratings:**

Checked boxes indicate the status of environmental ratings following implementation of this change. If below boxes are checked, there are no changes to the associated environmental ratings.

RoHS	REACH	Green Status	IEC 62474
☑ No Change	☑ No Change	⊠ No Change	🛮 No Change

#### Changes to product identification resulting from this PCN:

#### **Fab Site Information:**

Chip Site	Chip Site Origin Code (20L)	Chip Site Country Code (21L)	Chip Site City
DL-LIN	DLN	USA	Dallas
CFAB	CU3	CHN	Chengdu

Sample product shipping label (not actual product label):



MSL 1 /235C/UNLIM 03/29/04

OPT:
ITEM: 39

LBL: 5A (L)T0:1750



(1P) \$N74L\$07N\$R (Q) 2000 (D) 0336 (31T)LOT: 3959047MLA (4W) TKY(1T) 7523483812

(2P) REV: (20L) CSO: SHE (21L) CCO:USA (22L) ASO: MLA (23L) ACO: MYS

#### **Product Affected:**

**Group 1 Device list (DFAB to CFAB Wafer Fab site)** 

UCC28600D	UCC29002D	UCC29002DR	UCC39002D
UCC28600DR	UCC29002D/1	UCC29002DR/1	UCC39002DR

### **Group 2 Device list (DFAB to CFAB Wafer Fab site & BOM update)**

BQ30421DBT	BQ3055DBT	BQ30Z55DBT	BQ77PL157APW-4225
BQ30421DBTR	BQ30Z551DBTR-V100	BQ30Z55DBTR	BQ77PL157APWR-4225
BQ30424DBT	BQ30Z551DBT-V100	BQ30Z55DBT-R1	BQ8055DBT-D1
BQ30424DBTR	BQ30Z555DBT	BQ30Z55DBT-R2	BQ8055DBTR-D1
BQ30471DBTR	BQ30Z555DBTR	BQ30Z55DBTR-R1	BQ80S55DBT
BQ30471DBT-R1	BQ30Z555DBT-R2	BQ30Z55DBTR-R2	BQ80S55DBTR
BQ30471DBTR-R1	BQ30Z555DBTR-R2	BQ30Z55DBT-V100	

For alternate parts with similar or improved performance, please visit the product page on  $\overline{\text{TI.com}}$ 

# Qualification Report Approve Date 13-Jun-2022

## Qualification Results Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: BQ77PL157APWR-4225
ED	Electrical Characterization	Per Datasheet Parameters	1/30/0
CDM	ESD CDM	500V	1/3/0
HBM	ESD HBM	2500V	1/3/0
LU	Latch-up	per JESD78	1/6/0
MQ	Manufacturability (Assembly)	(per mfg. site specification)	1/PASS
MQ	Manufacturability (Wafer Fab)	(per mfg. site specification)	1/PASS

Qual Device BQ77PL157APWR-4225 is qualified at LEVEL2-260CG

Qual Device BQ77PL157APWR-4225 contains multiple dies.

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free (SMT) and Green

#### Qualification Report Approve Date 06-MAY-2022

#### Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	#	Test Name	Condition	Duration	Qual Device: BQ24085DRCR	Package QBS: TPS63000DRCR	Package QBS: MSP430FR5969IRGZR	Process QBS: <u>SN65HVDA195QDRQ1</u>
HAST	A2	Biased HAST	130C/85%RH	96 Hours	-	-	3/231/0	3/231/0
UHAST	A3	Autoclave	121C/15psig	96 Hours	-	3/231/0	3/231/0	3/231/0
TC	A4	Temperature Cycle	-65C/150C	500 Cycles	-	3/231/0	3/231/0	3/231/0
HTSL	A6	High Temperature Storage Life	175C	500 Hours	-	-	-	1/45/0
HTSL	A6	High Temperature Storage Life	150C	1000 Hours	-	-	3/231/0	-
HTOL	B1	Life Test	125C	1000 Hours	-	-	-	3/231/0
ELFR	B2	Early Life Failure Rate	125C	48 Hours	-	-	-	3/2400/0
SD	C3	PB Solderability	Precondition w.155C Dry Bake (4 hrs +/- 15 minutes)	-	-	-	-	1/15/0
SD	C3	PB-Free Solderability	Precondition w.155C Dry Bake (4 hrs +/- 15 minutes)	-	-	3/66/0	-	1/15/0
PD	C4	Physical Dimensions	Cpk>1.67	-	-	3/15/0	-	3/30/0
ESD	E2	ESD CDM	-	2000 Volts	1/3/0	-	-	-
ESD	E2	ESD HBM	-	3000 Volts	1/3/0	-	-	-
LU	E3	Latch-up	-	Per JESD78	1/6/0	-	-	-
CHAR	E5	Electrical Distributions	Cpk>1.67 Room, hot, and cold	-	1/Pass	-	-	3/90/0

- QBS: Qual By Similarity
- Qual Device BQ24085DRCR is qualified at MSL2 260C
- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the contact shown below or your local Field Sales Representative.

Location	E-Mail
WW Change Management Team	PCN ww admin team@list.ti.com

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